

Application/Control No.	Applicant(s)/Patent under Reexamination
10/725,554	CHEN, OWEN
Examiner	Art Unit
Anabel M. Ton	2875

	SEAR	CHED	
Class	Subclass	Date	Examiner
362	updated	2/1/2007	AT
315	updated		
40	updated		

INT	ERFERENC	RENCE SEARCHED		
Class	Subclass	Date	Examiner	
PgPbus	see	2/1/2007	AT	
	attached			
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(INCLUDING SEARCH STRATEGY)				
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